

Development of μ -PIC and its imaging properties

Tsutomu Nagayoshi

Kyoto University

H. Kubo, K. Miuchi, R. Orito,
A. Takada, A. Takeda,
T. Tanimori, M. Ueno

Espoo-Vantaa
Institute of Technology

O. Bouianov

Imaging2003 @ The Royal Swedish Academy of Science

June 26, 2003

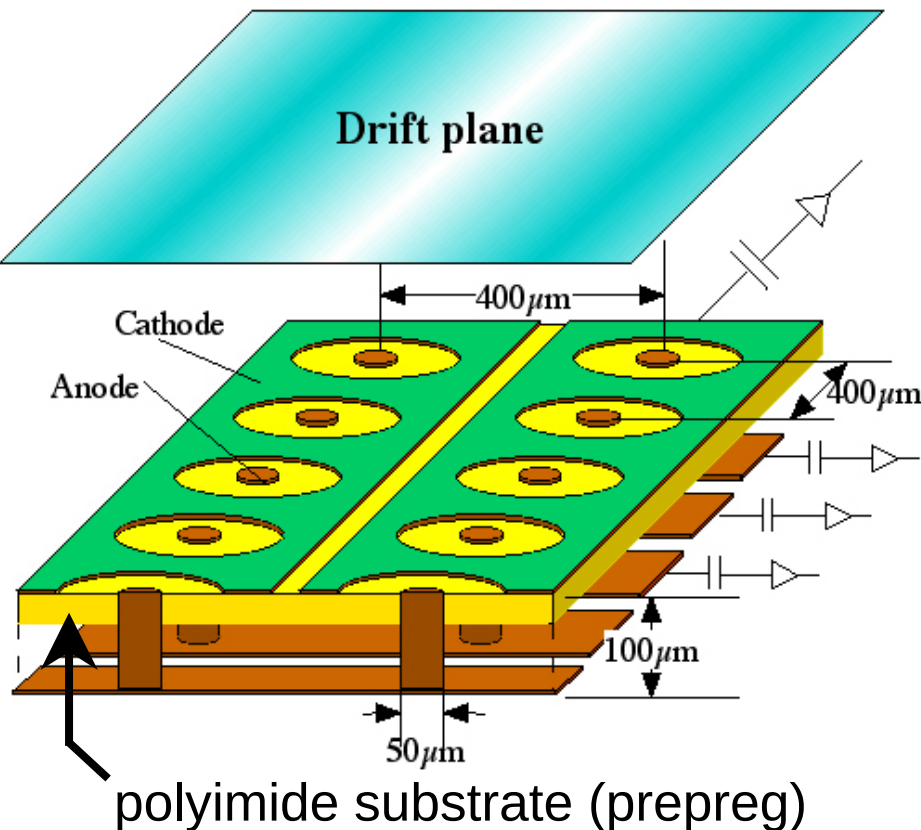


Contents

1. Micro Pixel Chamber (μ -PIC)
and application of μ -PIC
2. X-ray imaging properties
3. Charged particle tracking
4. Recent development

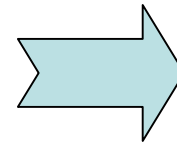


Micro Pixel Chamber (μ -PIC)

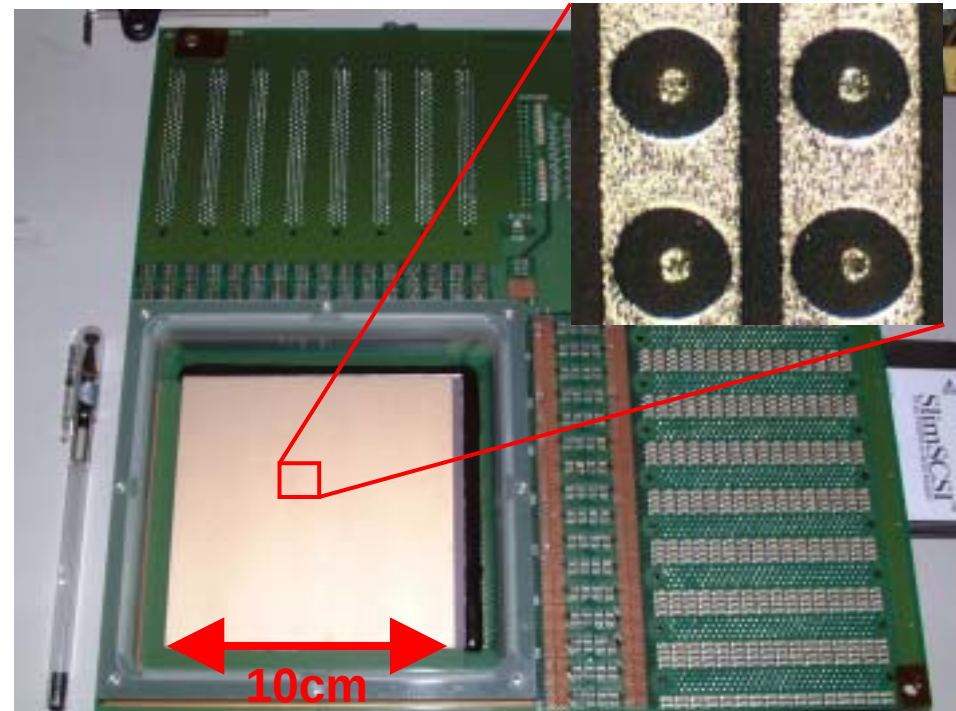


- $400\mu\text{m}$ pitch electrodes
- 256 anodes and 256 cathodes

Printed Circuit Board (PCB) technology



- Large area
- Low cost



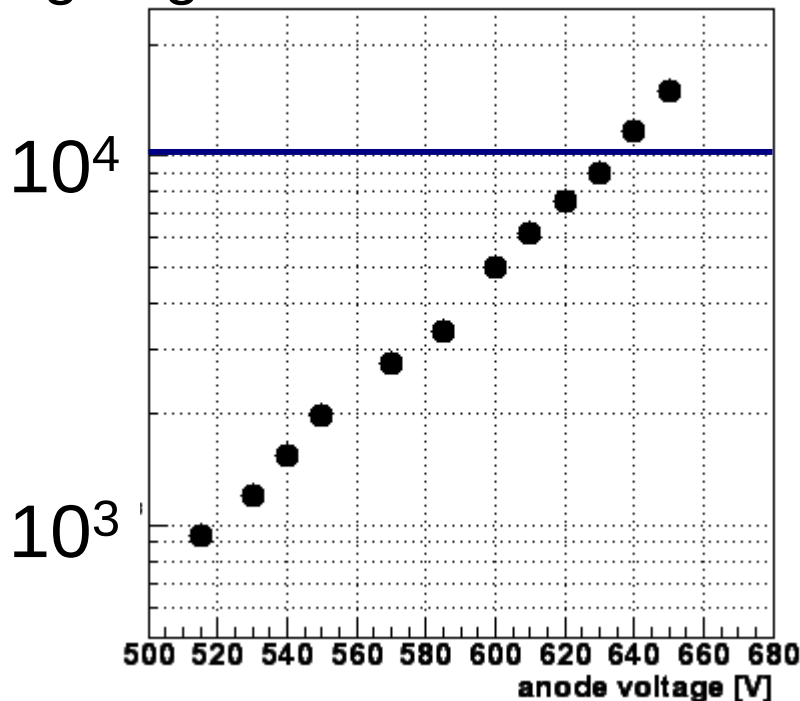
Detection area = 100cm^2

Performances

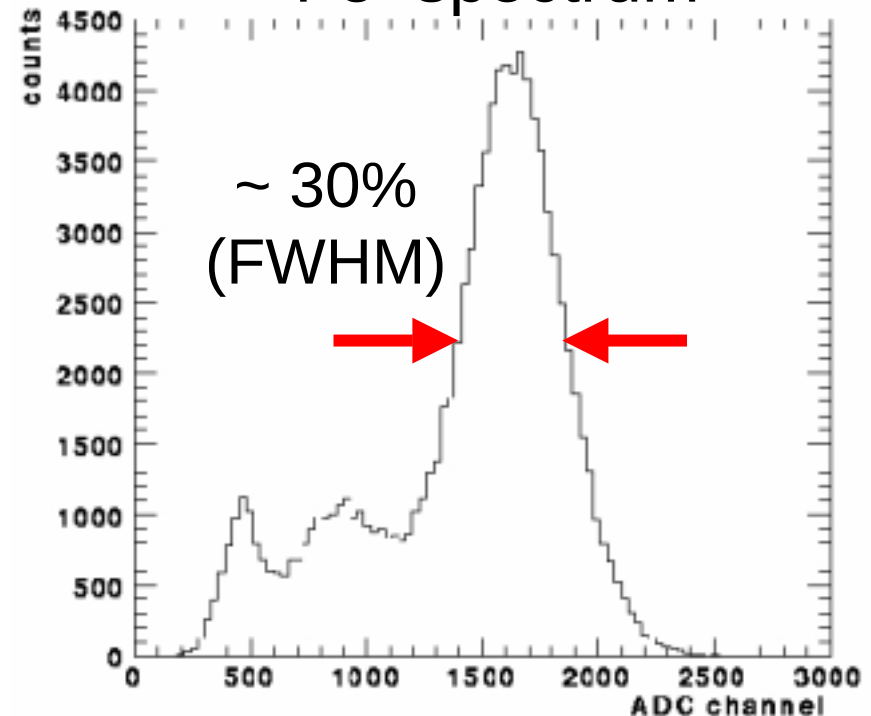
Gas: Ar/C₂H₆ (80/20)

Source: ⁵⁵Fe (5.9keV)

gas gain



⁵⁵Fe spectrum



- Gas gain ~ **15,000** (max)
- Stable operation (>**1000h**)
@ gas gain ~ 5000
- Energy resolution ~30%

Application of μ -PIC

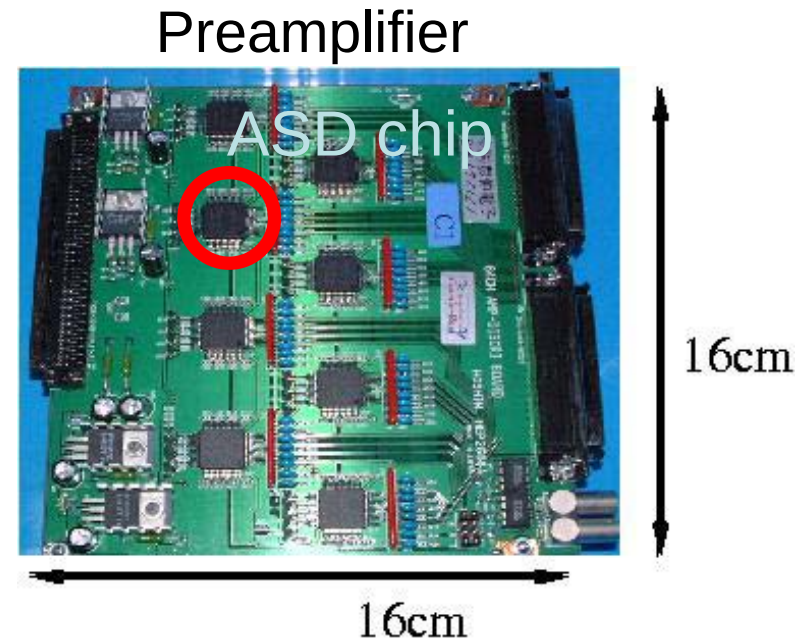
- X-ray imaging → astrophysics, crystal analysis, ...
 - X-ray **imaging and polarimetry**
 - *Next presentation (by Ueno)*
- Time Projection Chamber
 - Charged particle tracking
 - Gamma-ray imaging detector
 - *June 27th (by Orito)*
 - Neutron imaging detector



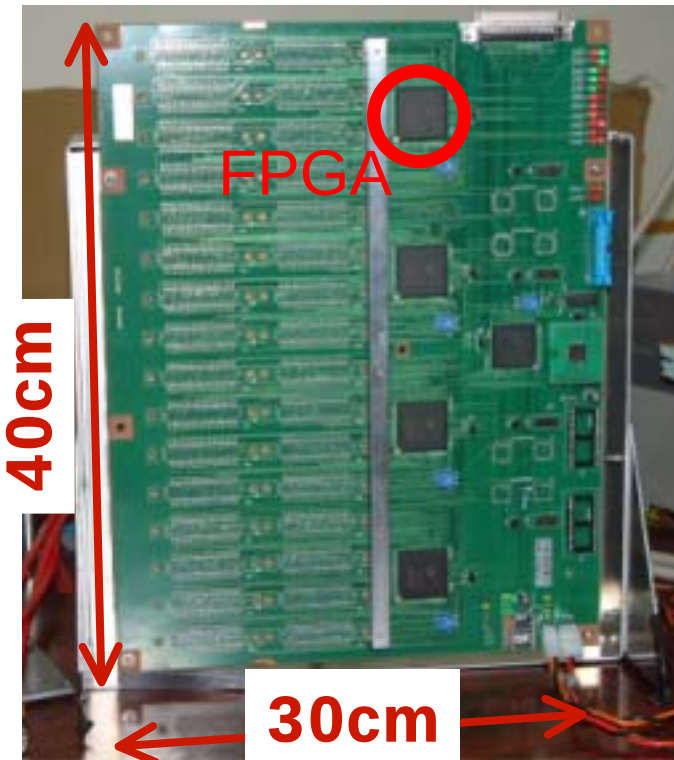
DAQ system

Preamplifier

ATLAS amplifier shaper
discriminator (**ASD**) chip
(64ch/card)

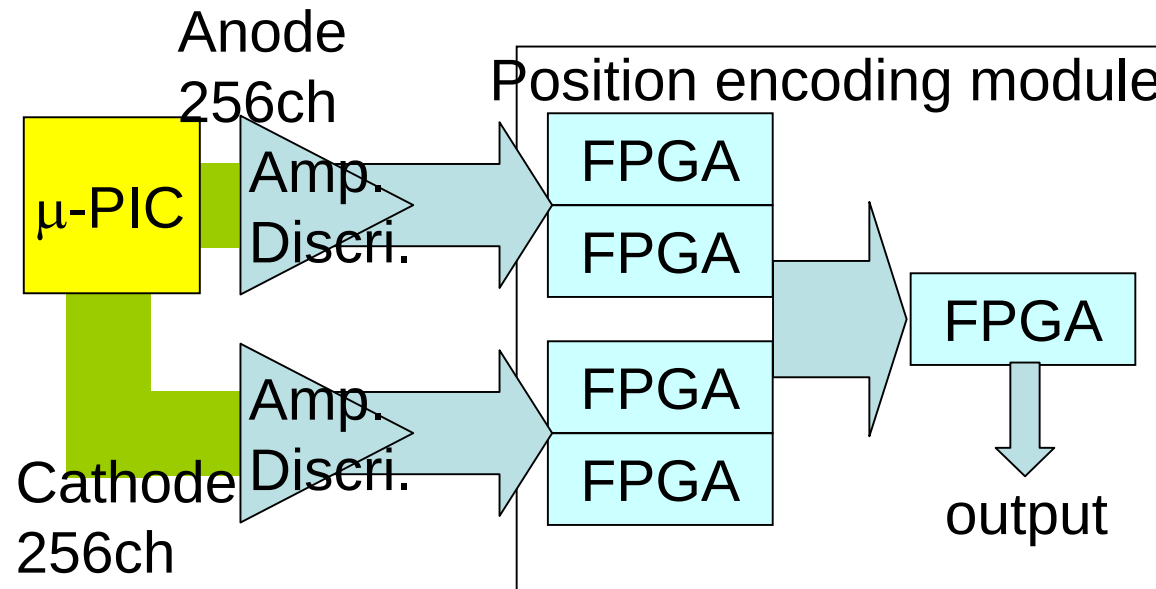


Position encoding module



Position encoding module

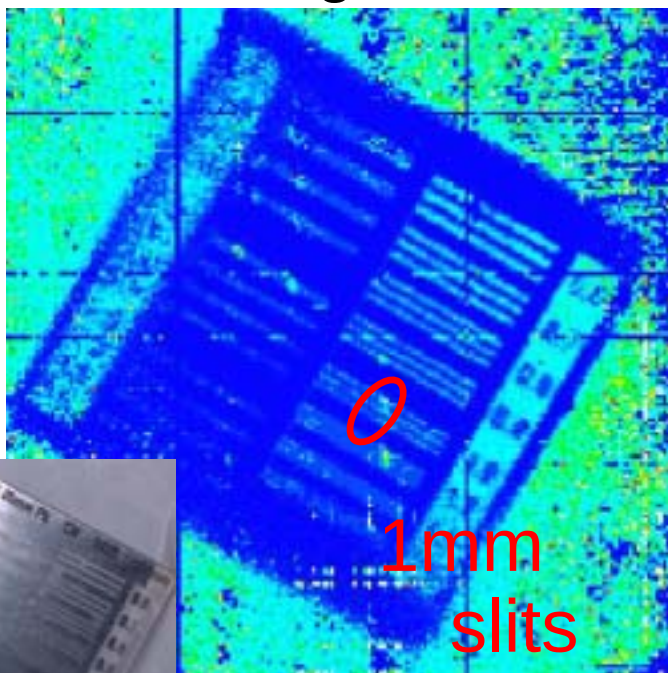
5 **FPGAs** (clock 20MHz)



X-ray imaging ~ Position resolution ~

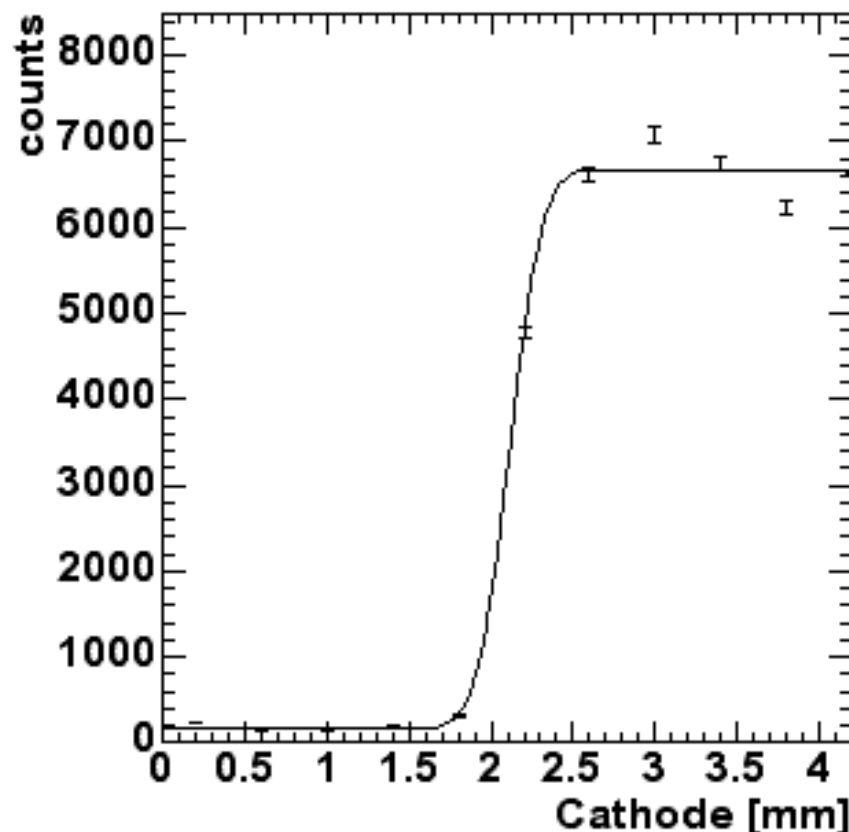
- Gas: Xe/C₂H₆ (70/30)
- Drift: 3mm (500V/cm)

Test chart image



Miuchi et al. 2002

Knife edge test



Position resolution

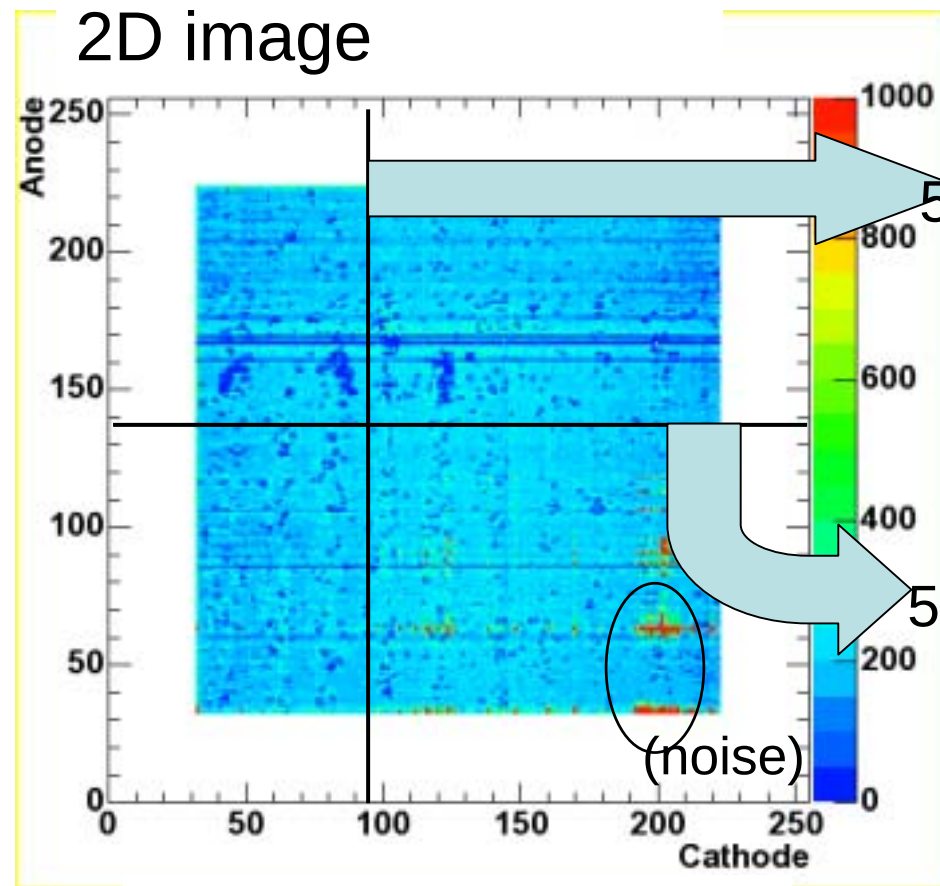
$\sigma \sim 160 \mu\text{m}$

(Theory ... $\sigma = 115 \mu\text{m}$)

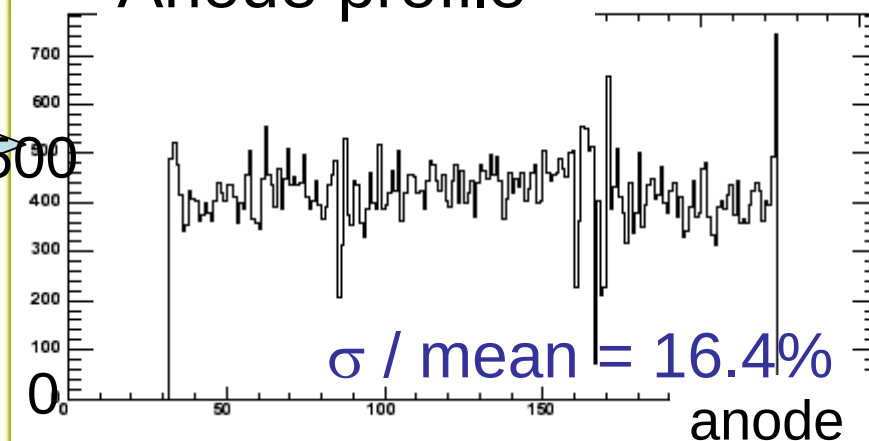


X-ray imaging ~ image uniformity ~

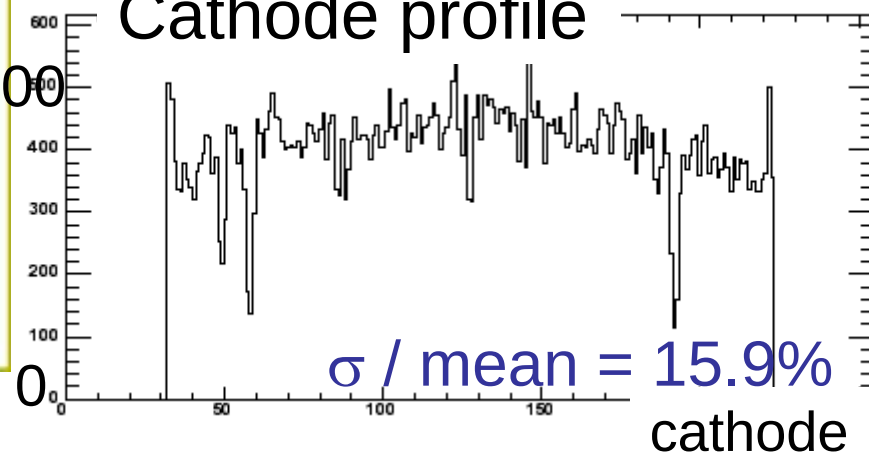
2D image



Anode profile



Cathode profile

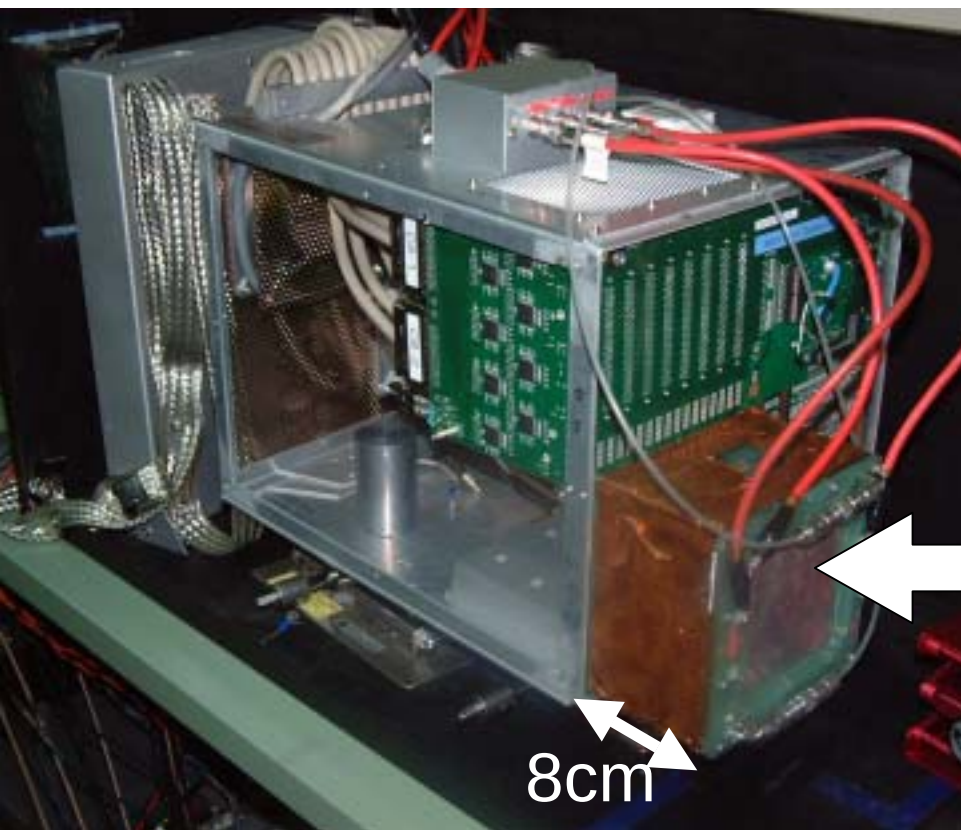


- Continuous X-ray ($E < 20\text{keV}$)
- Uniformly irradiated

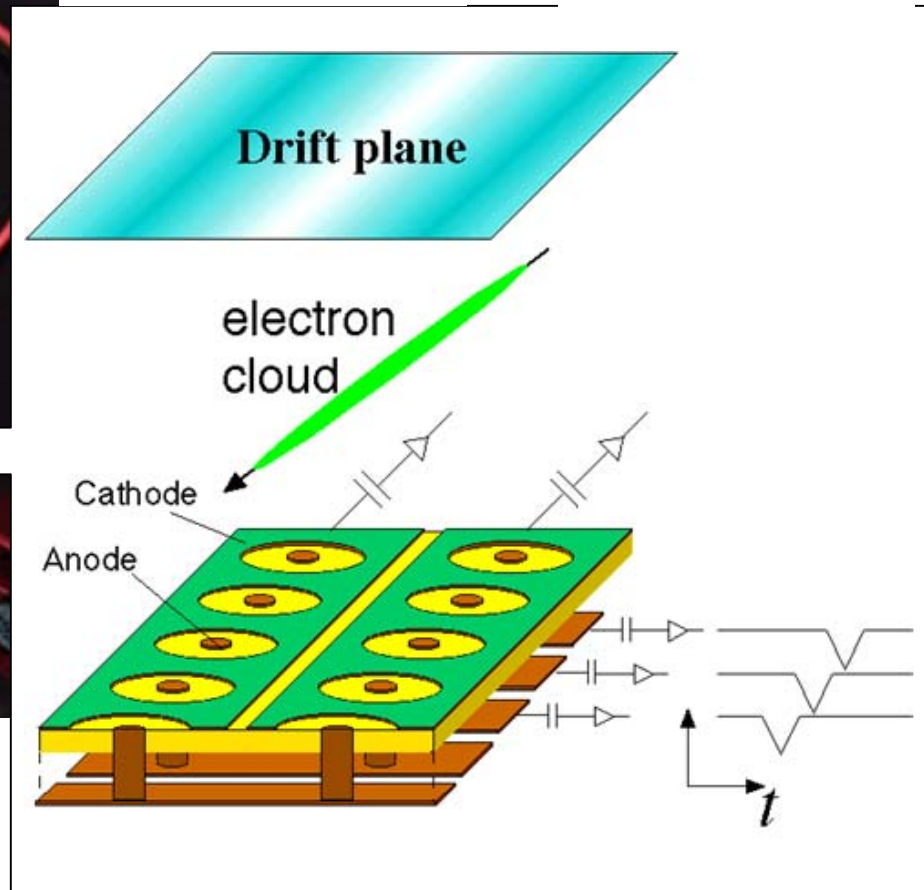
Almost uniform image!



Charged particle imaging



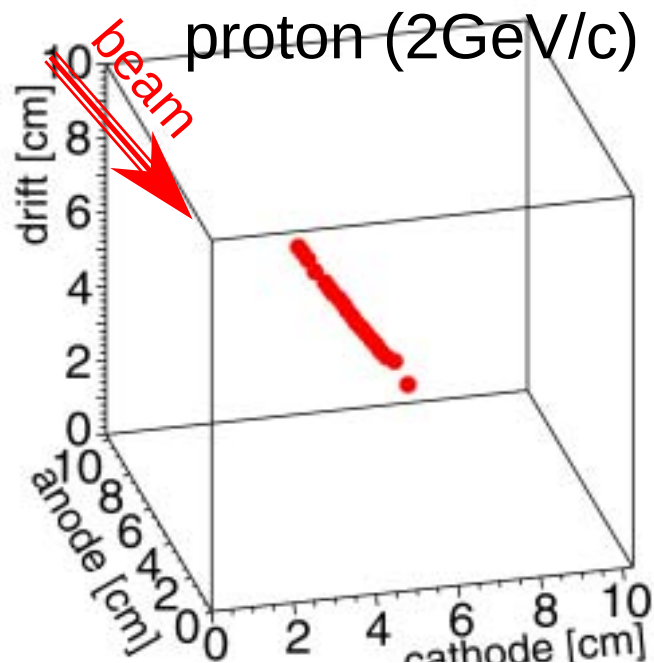
2D + timing $\longrightarrow$ 3D track



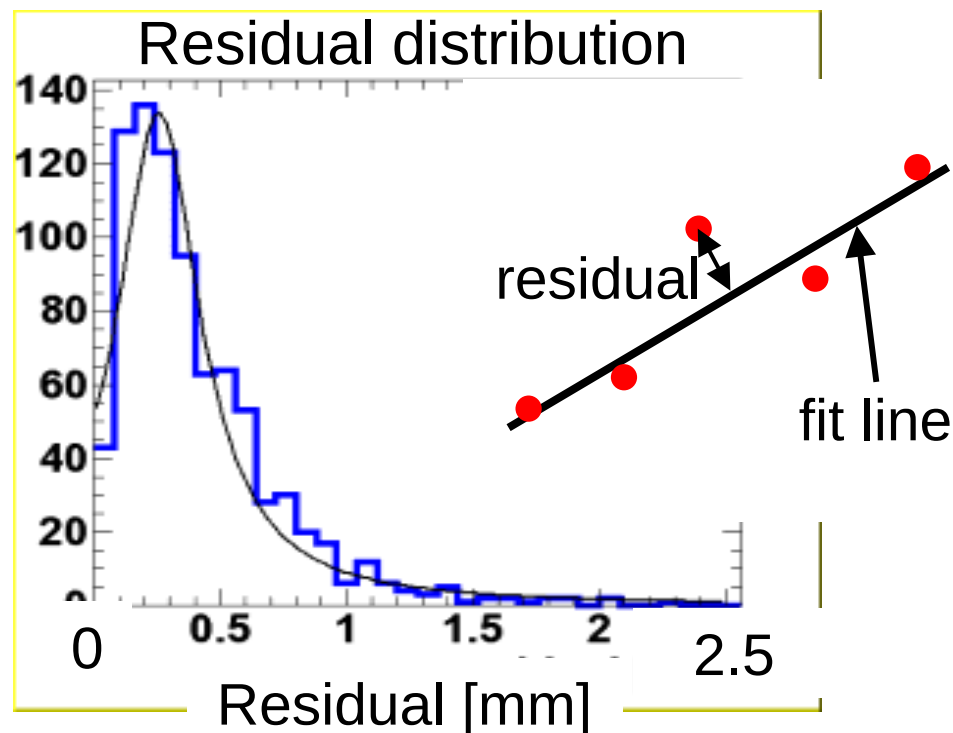
Micro-TPC based on μ -PIC

Charged particle tracking

(Gas: Ar and C₂H₆ mixture)



3D track → Linear fit



Ar/C₂H₆

Position resolution (RMS)

ratio

2D

3D

Drift velocity

80:20

250 μm

320 μm

(4.7cm/μsec)

90:10

200 μm

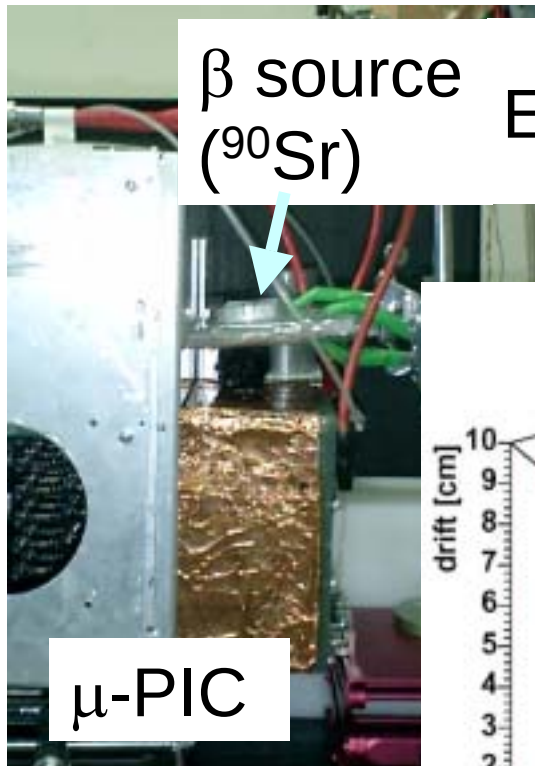
260 μm

(3.6cm/μsec)

Limited by
DAQ clock
(20MHz)

Charged particle tracking

~ Electron tracking ~

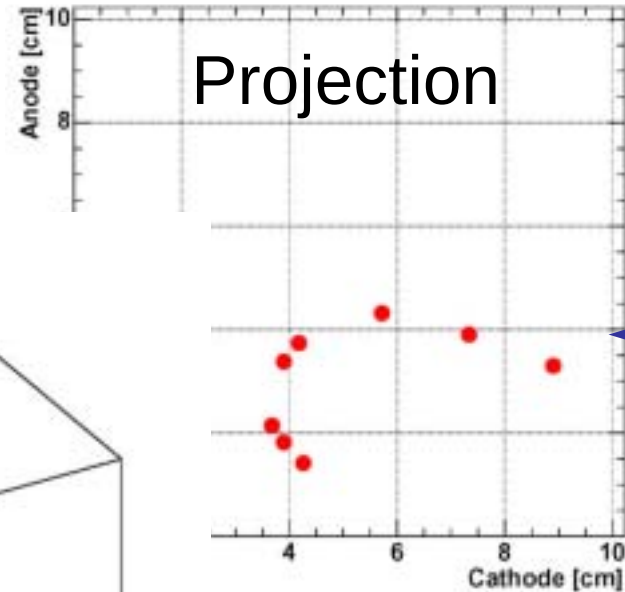
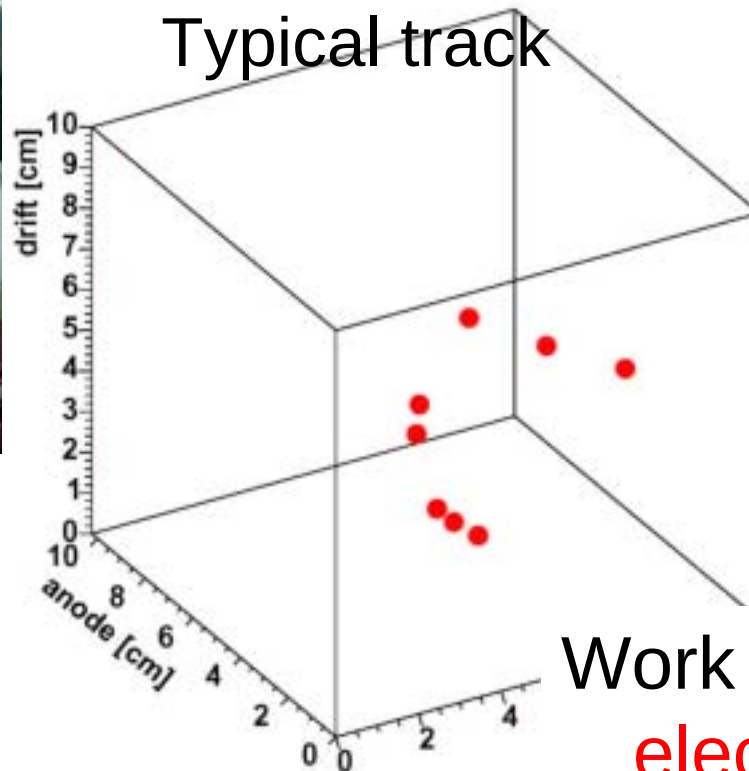


β source
(^{90}Sr)

$E < 2.3\text{MeV}$

μ -PIC

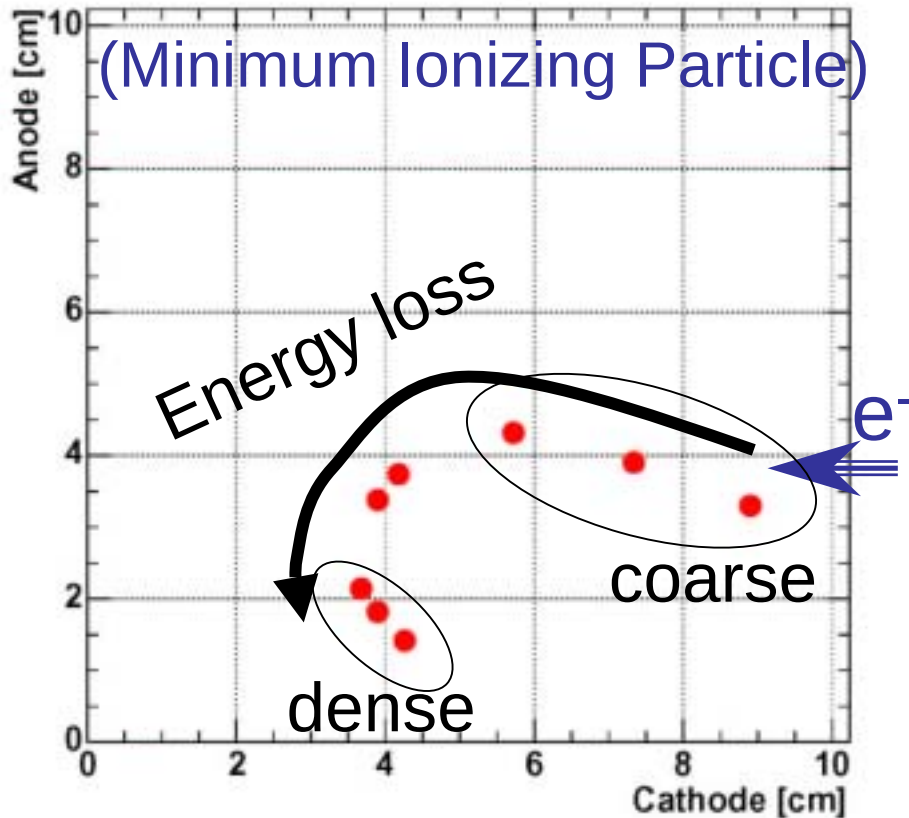
Set-up



Work as an
electric cloud chamber!

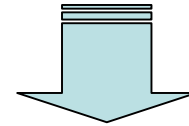
Problem of μ -PIC

Electron track ($E \sim 1\text{MeV}$)
(Minimum Ionizing Particle)



(Gas gain ~ 2000)

small $\frac{dE}{dx} \rightarrow$ Coarse plot



Gas gain is not enough.

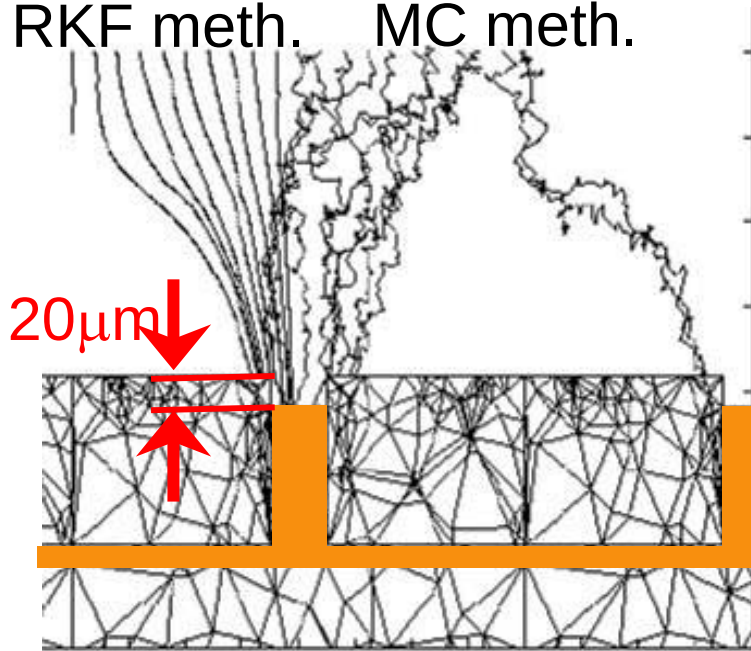
Required gain $> 10^4$
and
Stable operation

Drift simulation

~ For the best electrode ~

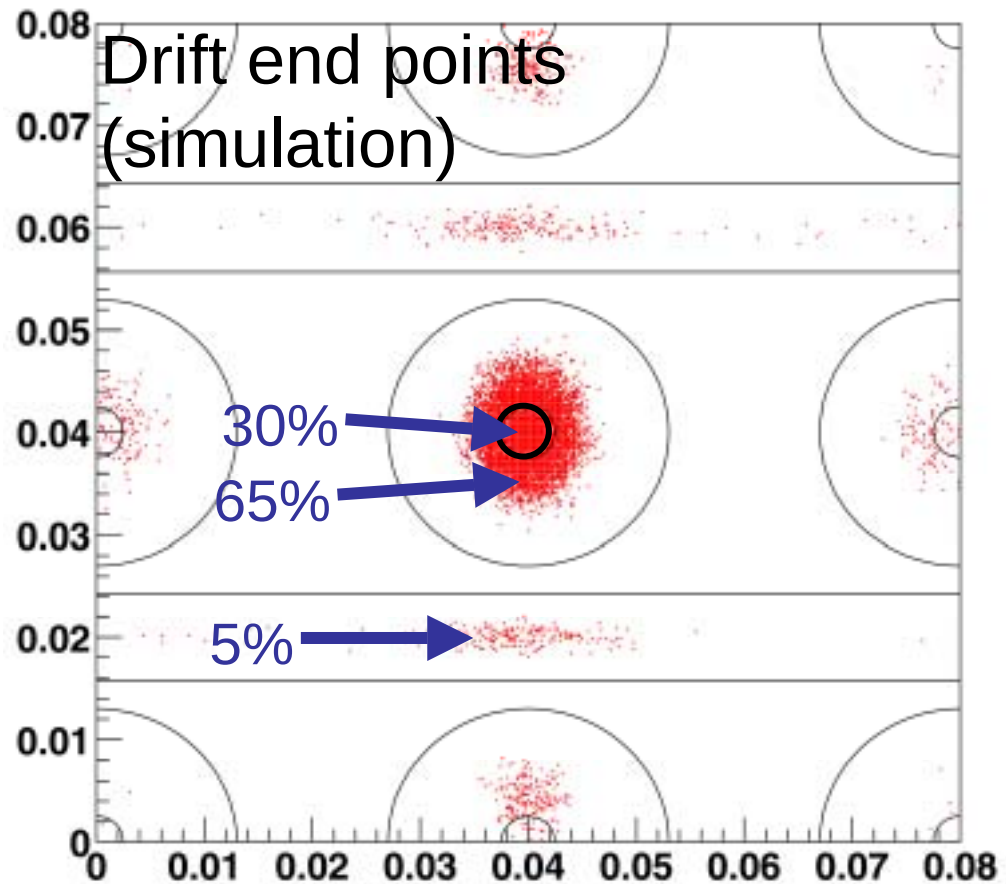
3D simulation
(Maxwell + Garfield)

RKF meth. MC meth.



Drift paths of electrons

Top of anode electrodes
are **below substrate**.



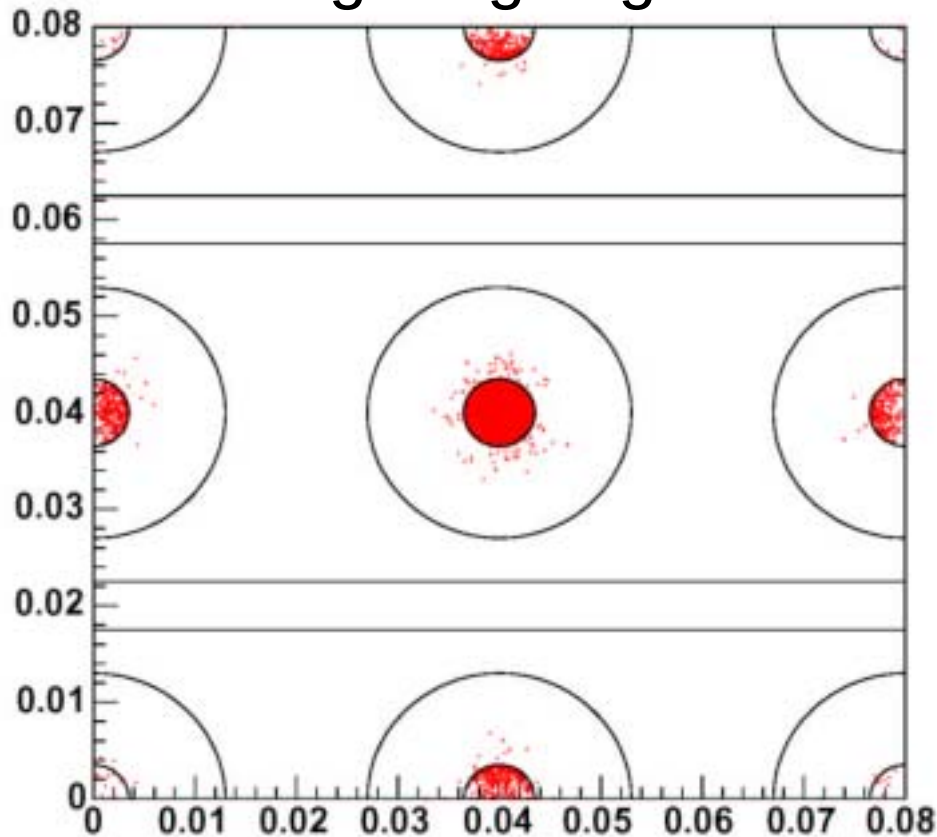
- Collection efficiency ~ 30%
- Low gas gain

Drift simulation ~ The best electrode? ~

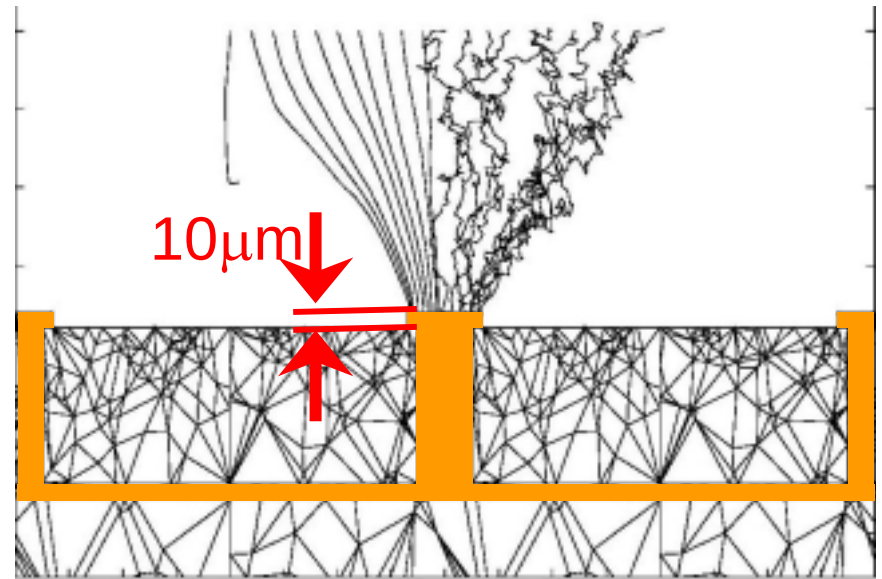
Higher anode

→ Higher efficiency

Higher gas gain



Drift end points (simulation)



Collection efficiency ~ **97%**

→ Gas gain: $\times 3$

Other improvement:
Gas selection, etc.

*New manufacture
technique is required.*

Future development

“Cap anode” μ -PIC

electrode formation process

- Current type ... normal plating (bottom-up)
- Cap anode ... plating and etching (top-down)

➔ Uniform electrodes will be made.

1. Electroless plating



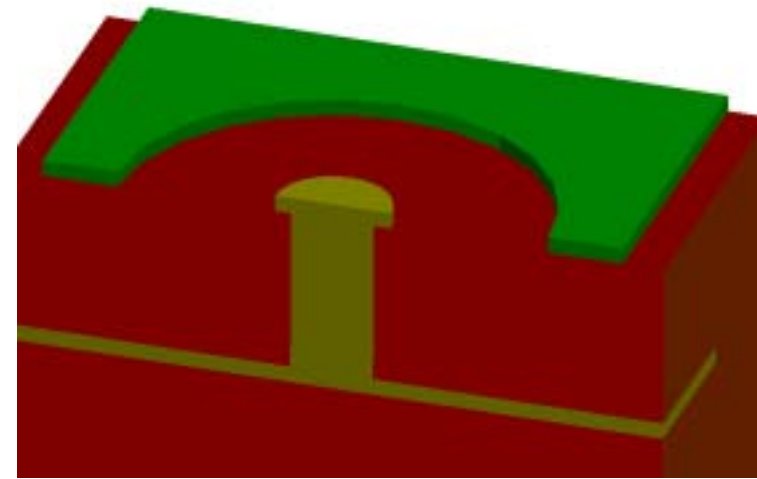
2. Via-fill plating



3. Surface etching



4. Electrode etching



Coming soon!!

Detection area
30cm × 30cm



Summary

- X-ray imaging property
 - Position resolution $\sim 160\mu\text{m}$
 - Uniform image was obtained
 - Charged particle imaging (Micro-TPC)
 - 3D tracking $\rightarrow$ position resolution $\sim 260\mu\text{m}$
 - Electron tracks were detected.
 - New electrode structure
 - Cap anode μ -PIC
 - $\rightarrow$ **High collection efficiency**
Uniform image
- } are expected.

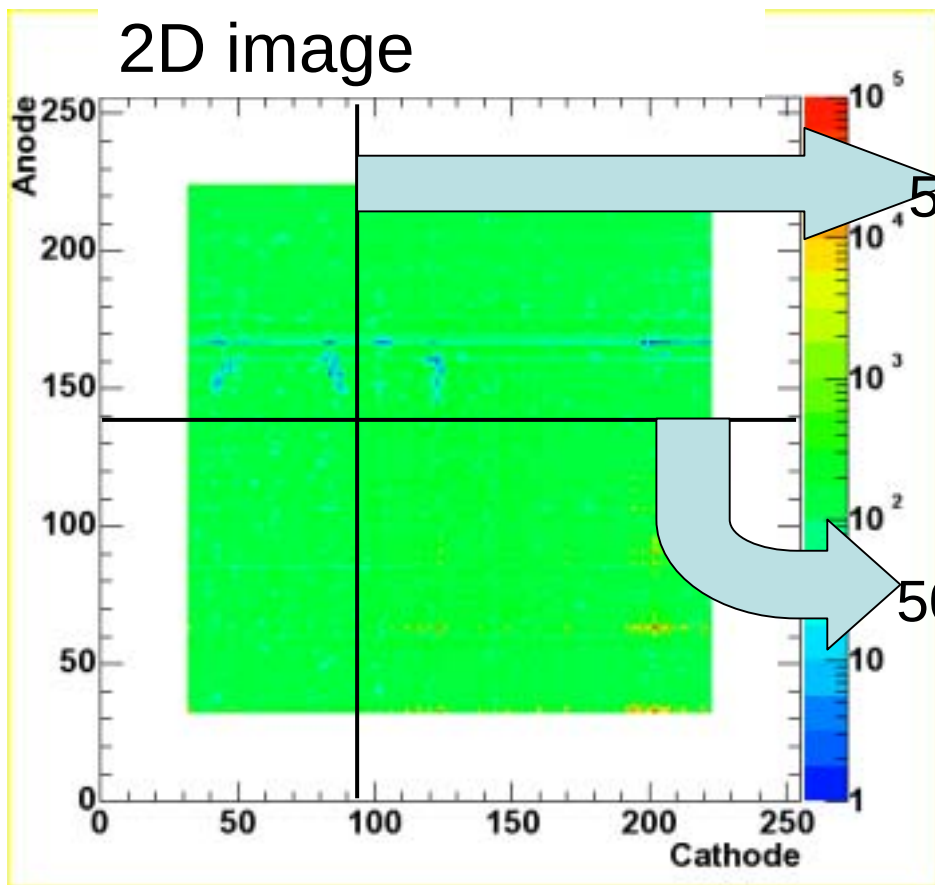
μ -PIC web site

<http://www-cr.scphys.kyoto-u.ac.jp/research/mu-PIC/index.html>

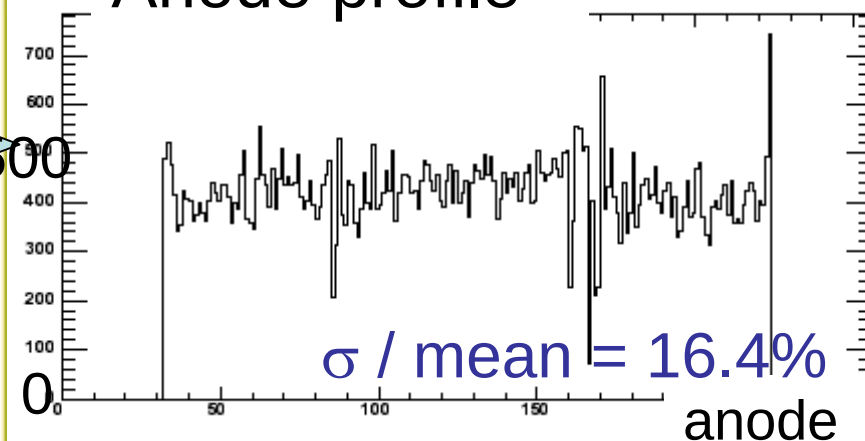


X-ray imaging ~ image uniformity ~

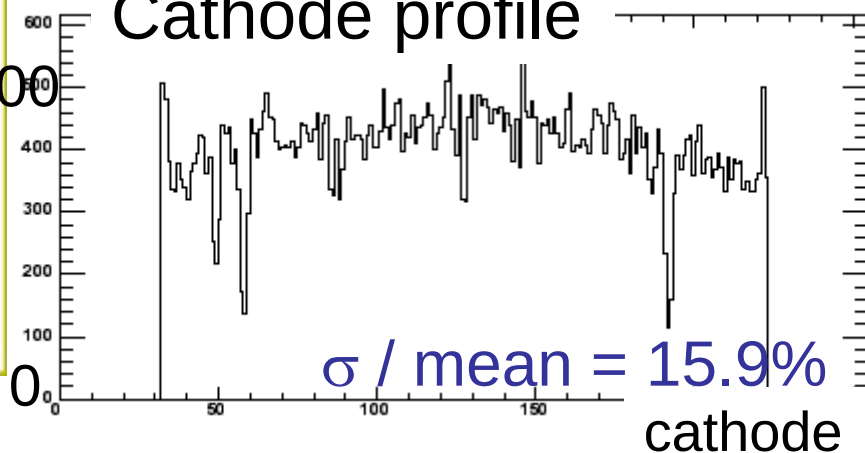
2D image



Anode profile



Cathode profile



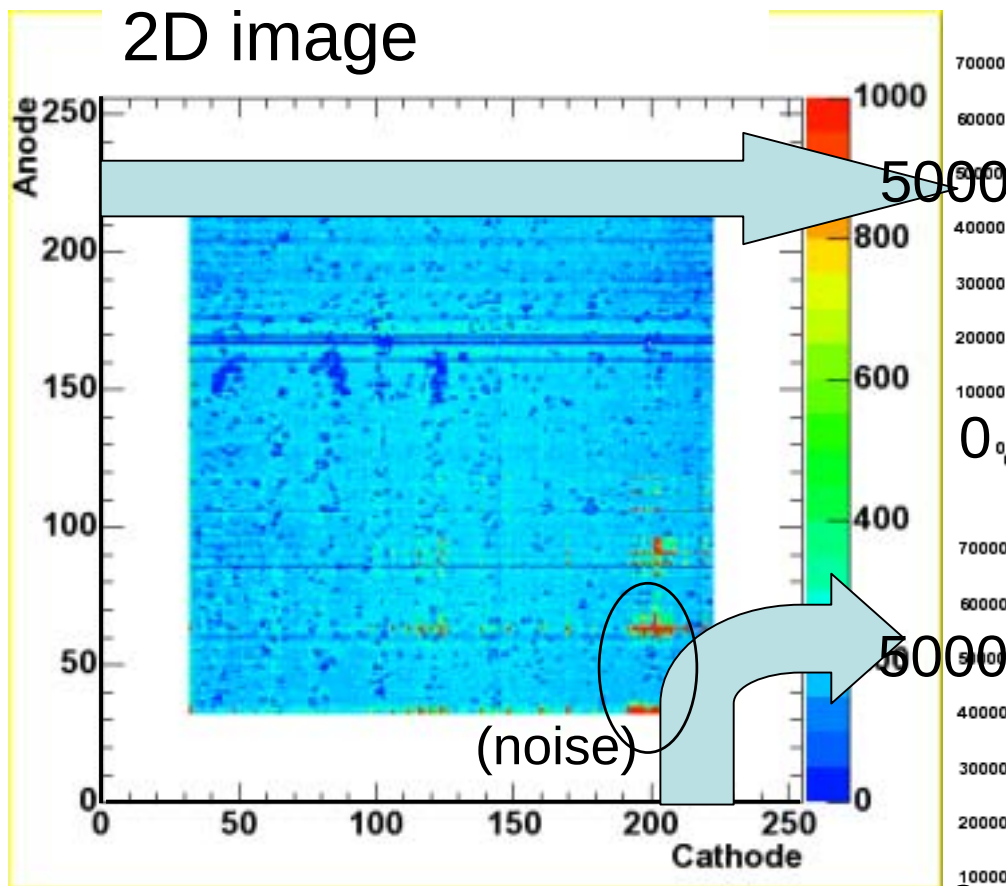
Continuous X-ray
($E < 20\text{keV}$)

Almost uniform
image was obtained.

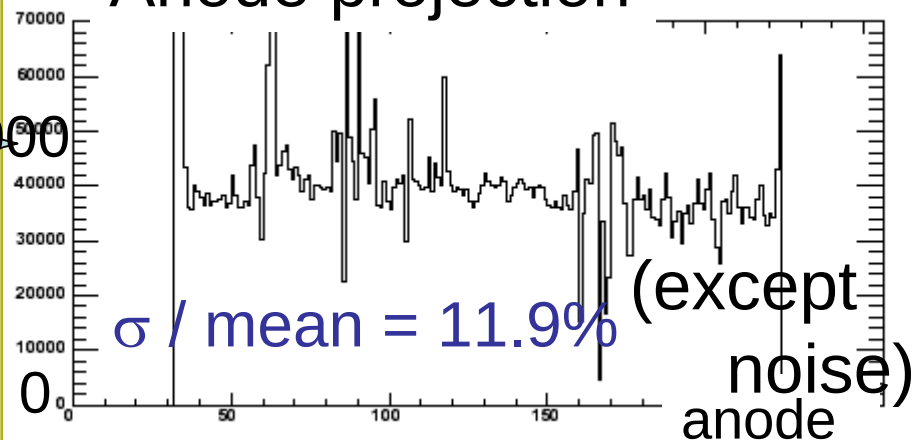


X-ray imaging ~ image uniformity ~

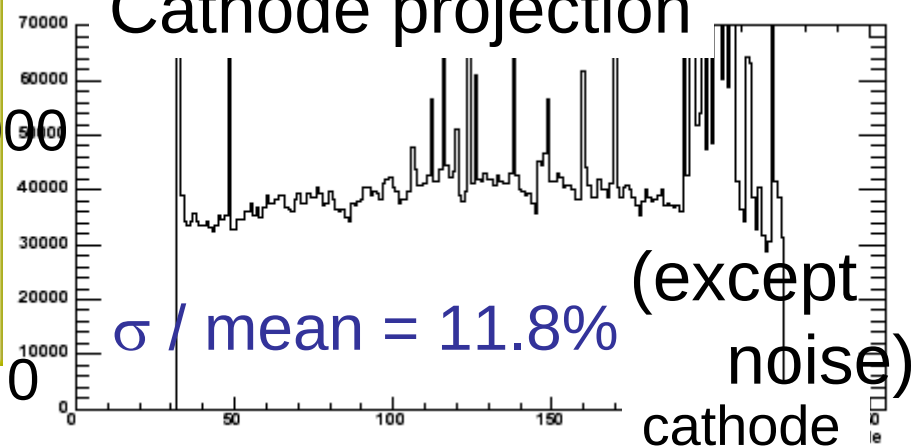
2D image



Anode projection



Cathode projection

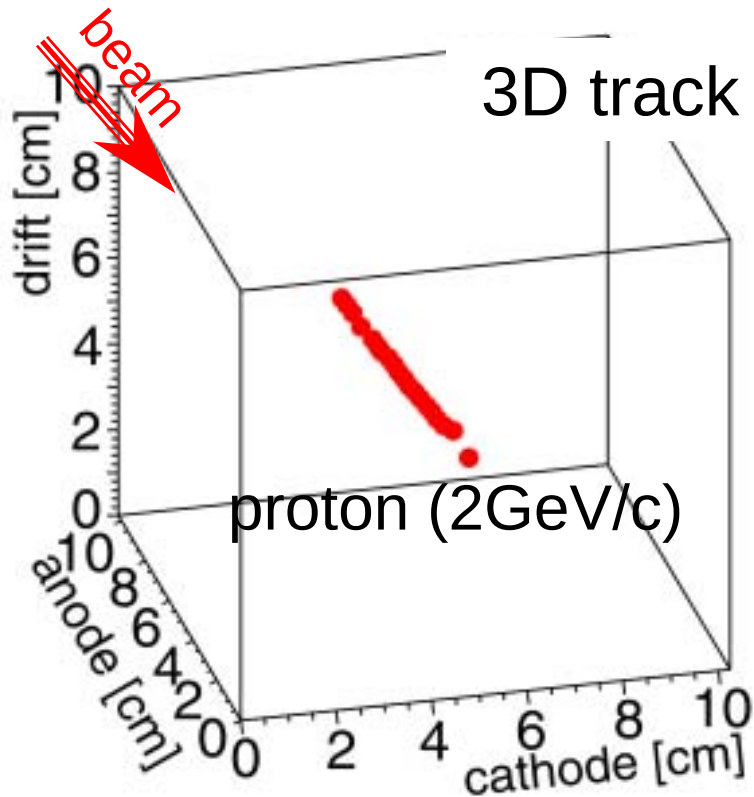


Continuous X-ray
($E < 20\text{keV}$)

Almost uniform
image was obtained.



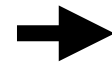
Charged particle tracking



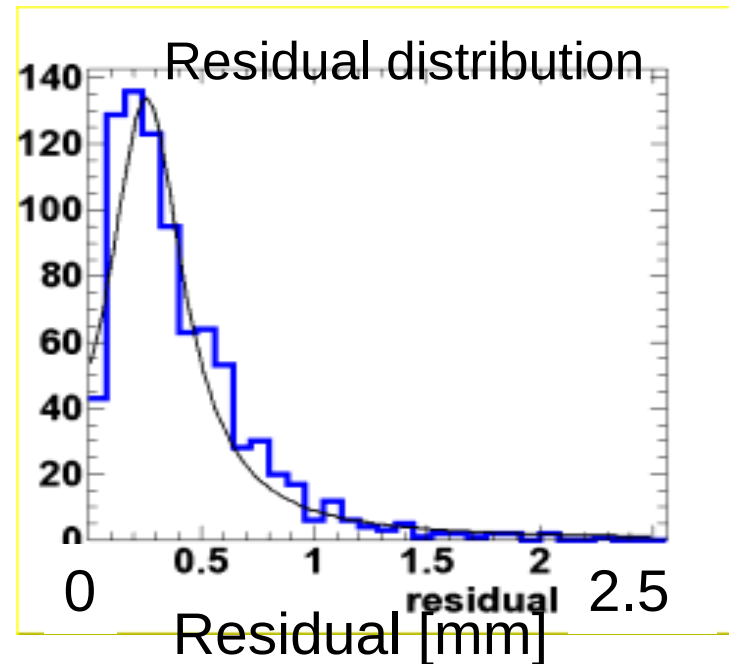
3D track



Linear fit



Residual distribution

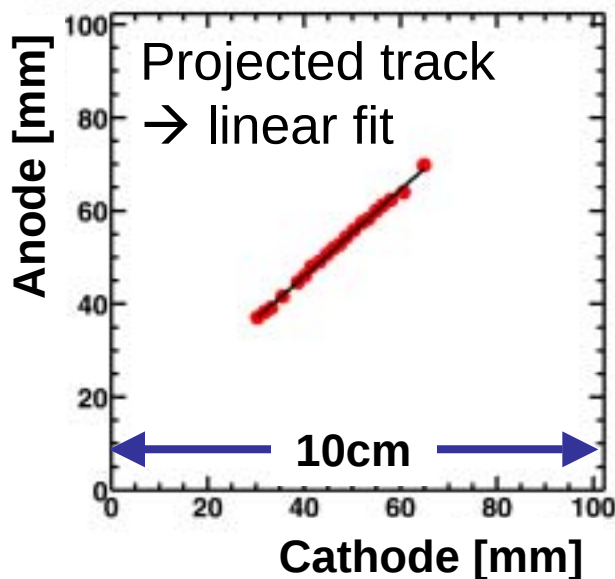
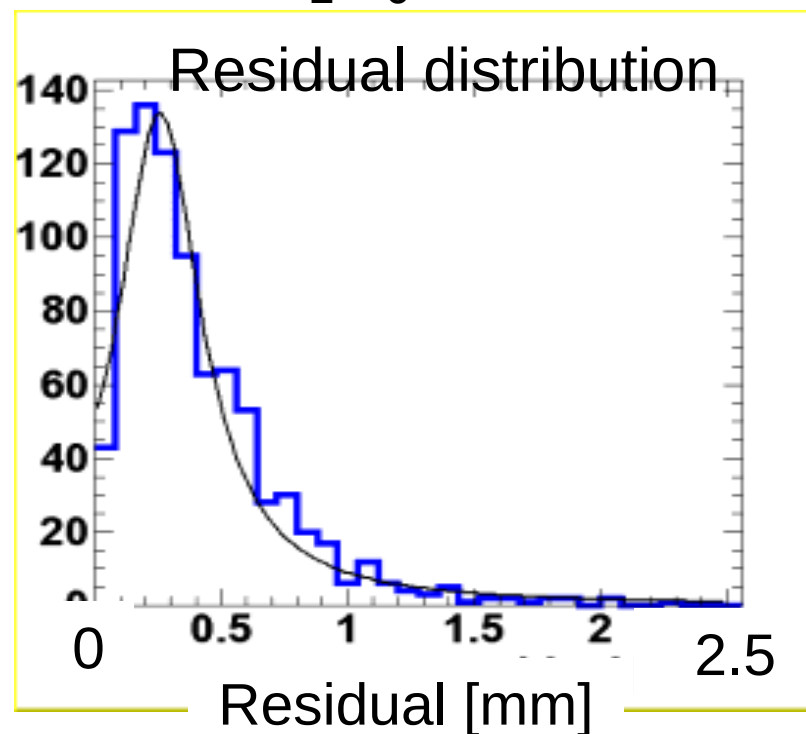
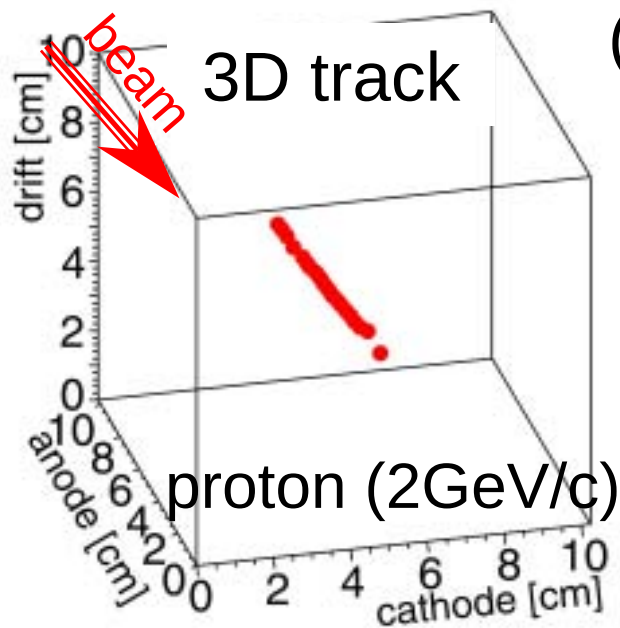


Position resolution (RMS)

- Ar/C₂H₆ 80/20 → 320 μm
- Ar/C₂H₆ 90/10 → 260 μm

Charged particle tracking

(Gas: Ar and C₂H₆ mixture)



Position resolution (RMS)

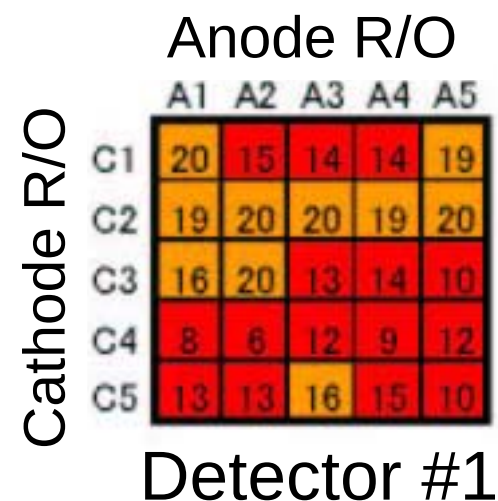
Ratio	2D	3D	Drift velocity
80:20	250 μm	320 μm	(4.7cm/ μsec)
90:10	200 μm	260 μm	(3.6cm/ μsec)

X-ray imaging ~ image uniformity (1) ~

Fluctuation of anode depth

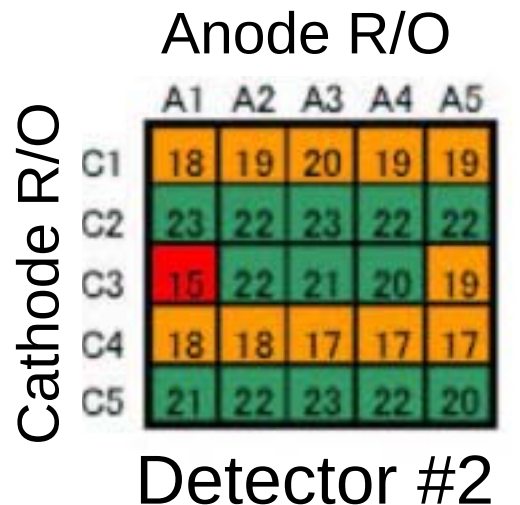
➔ Associated with image **uniformity**

Distribution of anode depth



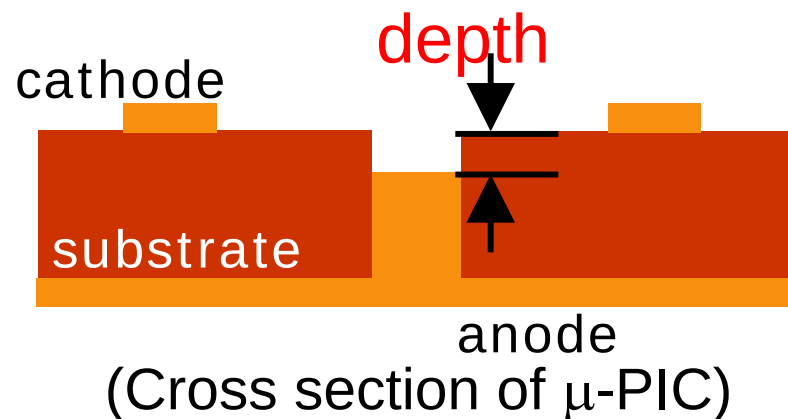
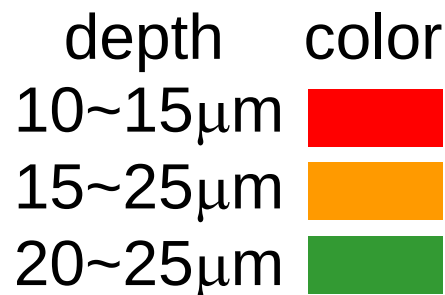
depth $14.7\mu\text{m}$

σ $4.2\mu\text{m}$

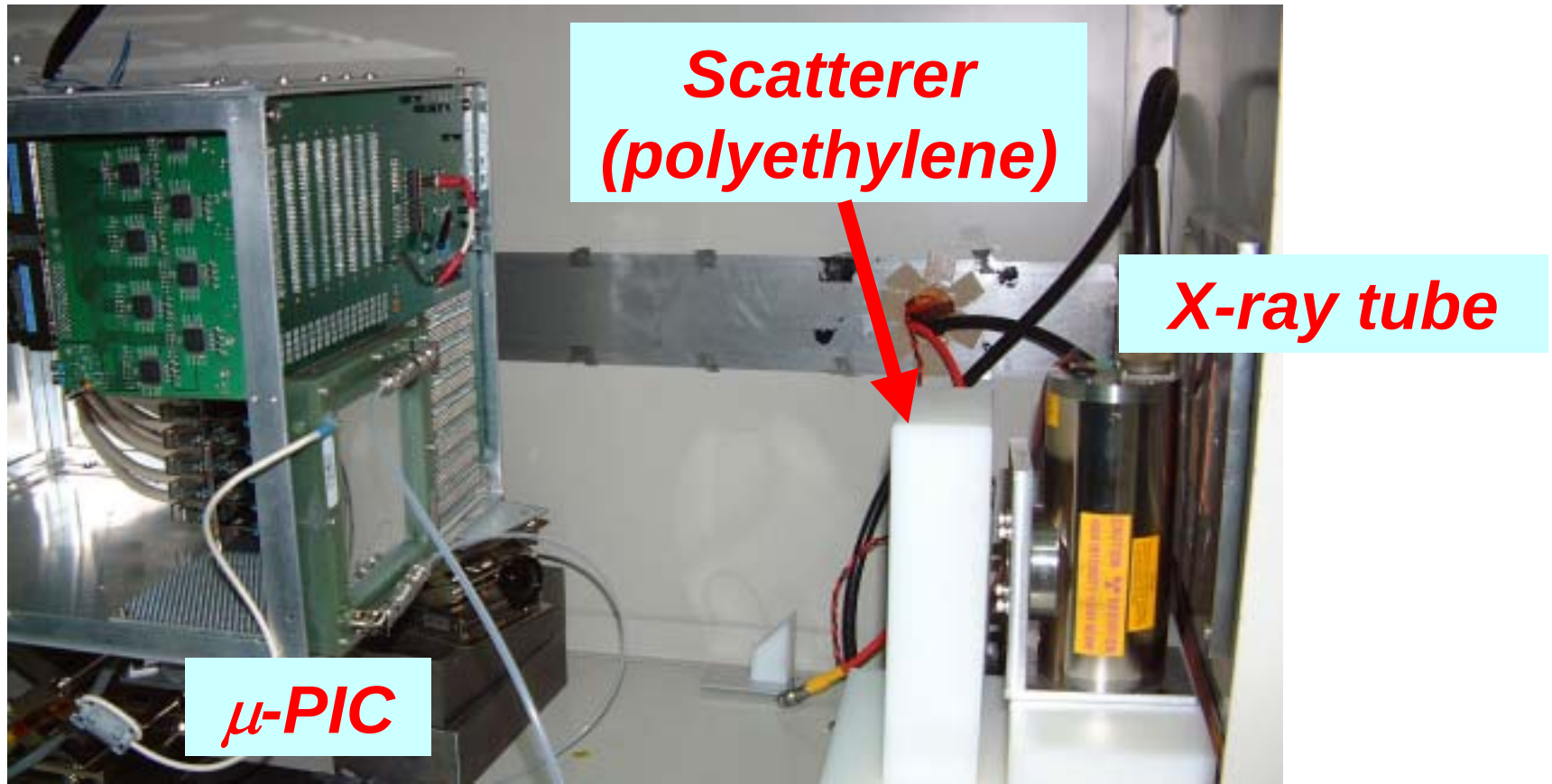


depth $20.0\mu\text{m}$

σ $2.2\mu\text{m}$



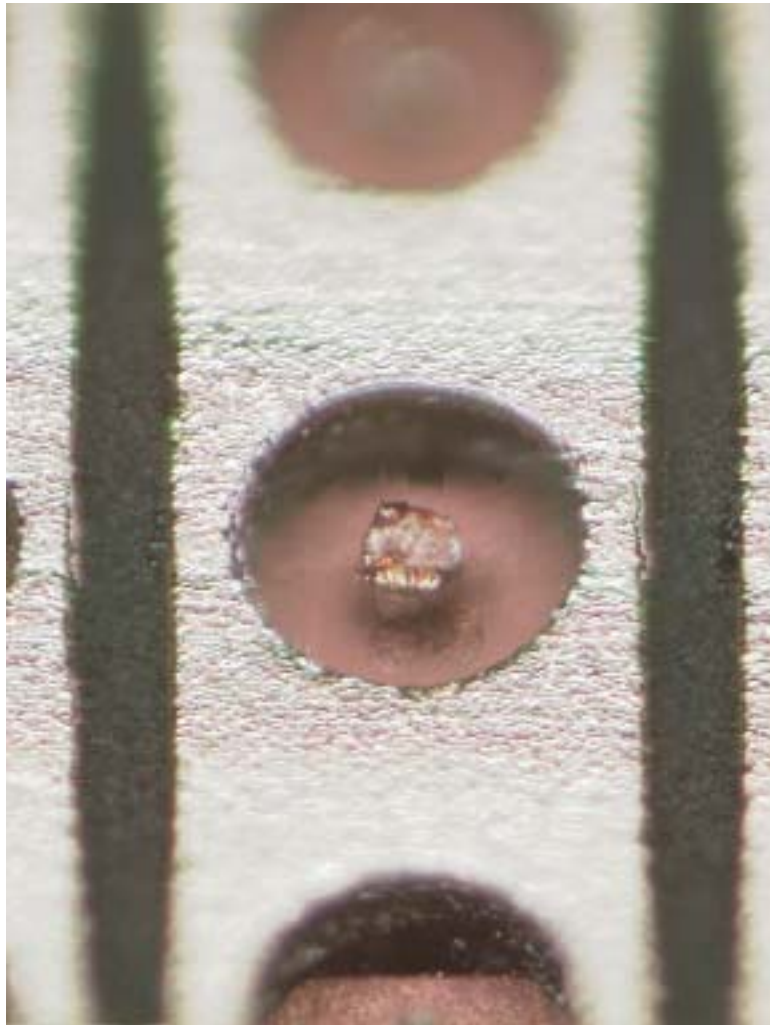
X-ray imaging ~ image uniformity (2) ~



- Source: X-ray tube (20kV)
- Gas: Ar/C₂H₆ (80/20)
- Uniformly irradiated

Resent development

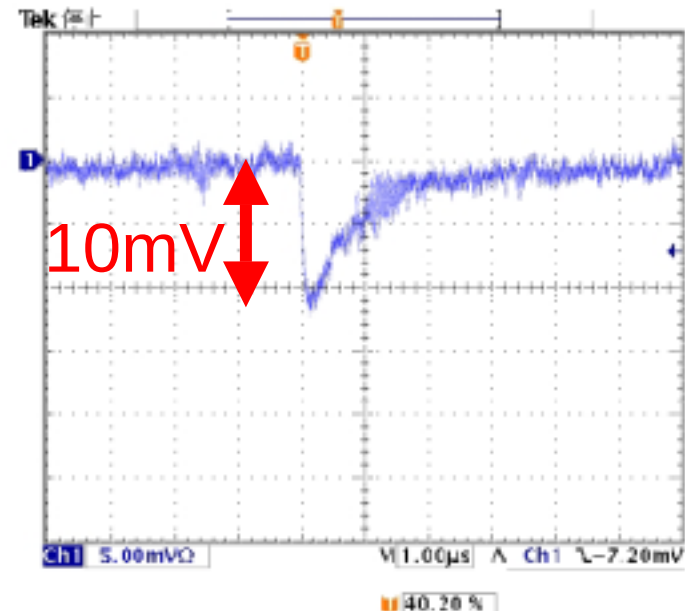
“Well type” μ -PIC



Laser ablation

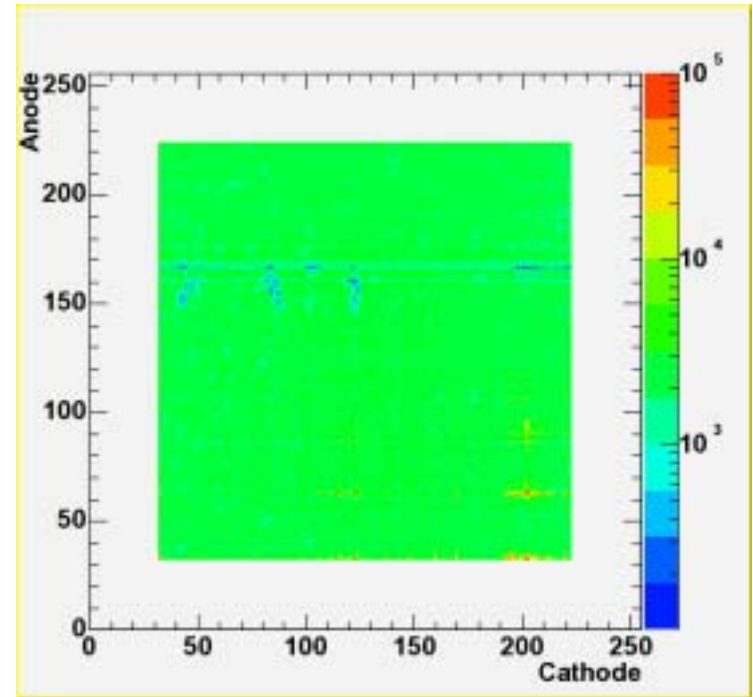
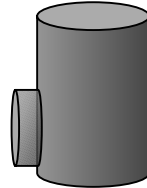
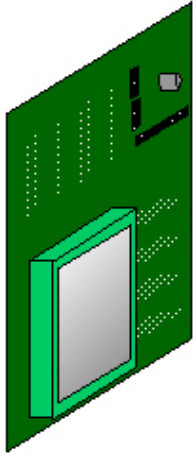
Collection efficiency ↗

Preliminary result



19 May 2003
18:12:54

X-ray imaging property



- Source: X-ray tube (20kV)
- Gas: Ar/C₂H₆ (80/20)
- Uniformly irradiated

Application of μ -PIC

- X-ray Imaging
 - X-ray astronomy
 - Crystal structure analysis
- X-ray polarization
 - ➔ *Next presentation (by Ueno)*
- Gamma-ray imaging
 - ➔ *27th, June (by Orito)*
- Charged particle tracking

